Advance Information

Power MOSFET 74 Amps, 30 Volts

N-Channel TO-220 and D2PAK

Features

- Low RDS(on)
- Higher Efficiency Extending Battery Life
- Diode Exhibits High Speed, Soft Recovery
- Avalanche Energy Specified
- IDSS Specified at Elevated Temperature

Typical Applications

- DC-DC Converters
- Low Voltage Motor Control
- Power Management in Portable and Battery Powered Products: Ie: Computers, Printers, Cellular and Cordless Telephones, and PCMCIA Cards

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	VDSS	30	Vdc
Drain–to–Gate Voltage (R _{GS} = 10 MΩ)	VDGR	30	Vdc
Gate-to-Source Voltage - Continuous	V _{GS}	±20	Vdc
Drain Current - Continuous @ $T_A = 25^{\circ}C$ - Continuous @ $T_A = 100^{\circ}C$ - Single Pulse ($t_p \le 10 \mu s$)	IDW	74 47 175	Adc Apk
Total Power Dissipation @ T _A = 25°C Derate above 25°C	PD	80 0.66	W/°C
Operating and Storage Temperature Range	T _J , T _{stg}	-55 to +150	°C
Single Pulse Drain–to–Source Avalanche Energy – Starting $T_J = 25^{\circ}C$ ($V_{DD} = 30$ Vdc, $V_{GS} = 10$ Vdc, $L = 5.0$ mH $I_{L(pk)} = 17$ A, $V_{DS} = 30$ Vdc, $R_G = 25 \Omega$)	EAS	722	mJ
Thermal Resistance – Junction–to–Case – Junction–to–Ambient (Note 1)	R _θ JC R _θ JA	1.55 70	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	TL	260	°C

- When surface mounted to an FR4 Board using minimum recommended Pad Size, (Cu Area 0.412 in²).
- 2. Current limited by internal lead wires.

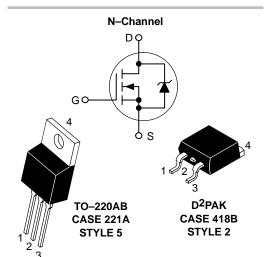
This document contains information on a new product. Specifications and information herein are subject to change without notice.



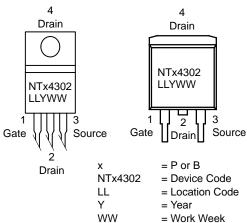
ON Semiconductor™

http://onsemi.com

74 AMPERES 30 VOLTS RDS(on) = 9.3 m Ω Max



MARKING DIAGRAMS & PIN ASSIGNMENTS



ORDERING INFORMATION

Device	Package	Shipping
NTP4302	TO-220AB	50 Units/Rail
NTB4302	D ² PAK	50 Units/Rail
NTB4302T4	D ² PAK	800/Tape & Reel

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

С	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS						
Drain-to-Source Breakdown V (V _{GS} = 0 Vdc, I _D = 250 μAd Temperature Coefficient (Positi	V(BR)DSS	30 -	_ 25	- -	Vdc mV/°C	
Zero Gate Voltage Drain Currer (VDS = 30 Vdc, VGS = 0 Vdc (VDS = 30 Vdc, VGS = 0 Vdc	IDSS	_ _	_ _	1.0 10	μAdc	
Gate-Body Leakage Current (\	$/_{GS} = \pm 20 \text{ Vdc}, V_{DS} = 0 \text{ Vdc})$	IGSS	_	_	±100	nAdc
ON CHARACTERISTICS (Note 3	3)					
Gate Threshold Voltage (Note 3 (V _{DS} = V _{GS} , I _D = 250 μAdo Threshold Temperature Coeffic	VGS(th)	1.0	1.9 -3.8	3.0	Vdc mV/°C	
Static Drain-to-Source On-Re (VGS = 10 Vdc, I _D = 37 Adc) (VGS = 10 Vdc, I _D = 20 Adc) (VGS = 4.5 Vdc, I _D = 10 Adc)	R _{DS(on)}	-	6.8 6.8 9.5	9.3 9.3 12.5	mΩ	
Forward Transconductance (No	ote 3) (V _{DS} = 10 Vdc, I _D = 20 Adc)	9FS	_	40	1	mhos
DYNAMIC CHARACTERISTICS						
Input Capacitance		C _{iss}	-	2050	2400	pF
Output Capacitance	$(V_{DS} = 24 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, f = 1.0 \text{ MHz})$	C _{oss}	-	640	800	
Transfer Capacitance] ,	C _{rss}	-	225	310	
SWITCHING CHARACTERISTIC	CS (Note 4)					
Turn-On Delay Time		^t d(on)	_	10	18	ns
Rise Time	$(V_{DD} = 24 \text{ Vdc}, I_{D} = 20 \text{ Adc},$	t _r	_	22	35	
Turn-Off Delay Time	$V_{GS} = 10 \text{ Vdc}, R_G = 2.5 \Omega) \text{ (Note 3)}$	td(off)	-	45	75	
Fall Time		t _f	-	35	70	
Turn-On Delay Time		^t d(on)	-	18	-	ns
Rise Time	$(V_{DD} = 24 \text{ Vdc}, I_{D} = 10 \text{ Adc},$	t _r	-	70	-	
Turn-Off Delay Time	$V_{GS} = 4.5 \text{ Vdc}, R_{G} = 2.5 \Omega) \text{ (Note 3)}$	td(off)	-	32	-	
Fall Time		tf	_	30	_	
Gate Charge	(V _{DS} = 24 Vdc, I _D = 37 Adc, V _{GS} = 4.5 Vdc) (Note 3)	QT	_	28	_	nC
		Qgs	_	7.5	_	
	193 110 120, (11010 0)	Q _{gd}	-	19	-	
SOURCE-DRAIN DIODE CHAR	ACTERISTICS		•	•		•
Forward On-Voltage	$(I_S = 20 \text{ Adc}, V_{GS} = 0 \text{ Vdc}) \text{ (Note 3)}$ $(I_S = 20 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_J = 125^{\circ}\text{C})$	V _{SD}	_ _	0.90 0.75	1.3 -	Vdc
Reverse Recovery Time		t _{rr}	-	37	-	ns
	(I _S = 20 Adc, V _G S = 0 Vdc, dI _S /dt = 100 A/μs) (Note 3)	ta	_	21	-	
	. 3	t _b	_	16	-	
Reverse Recovery Stored Cha	rge	Q _{RR}	-	0.035	-	μС
					•	

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

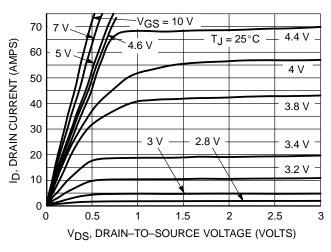


Figure 1. On-Region Characteristics

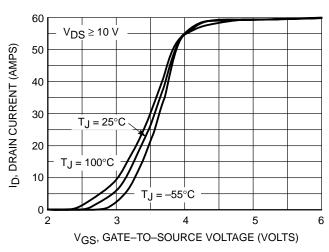


Figure 2. Transfer Characteristics

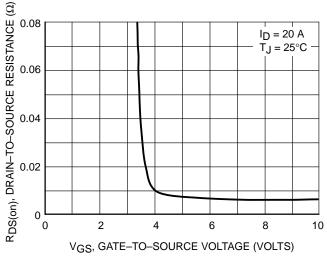


Figure 3. On-Resistance versus Gate-to-Source Voltage

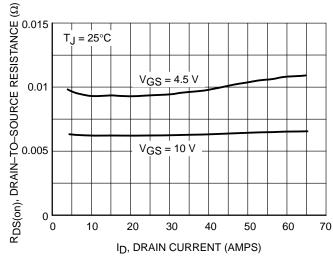


Figure 4. On-Resistance versus Drain Current and Gate Voltage

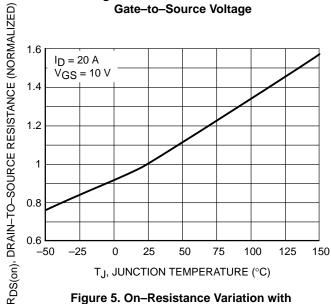


Figure 5. On-Resistance Variation with **Temperature**

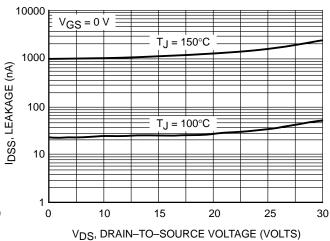


Figure 6. Drain-to-Source Leakage Current versus Voltage

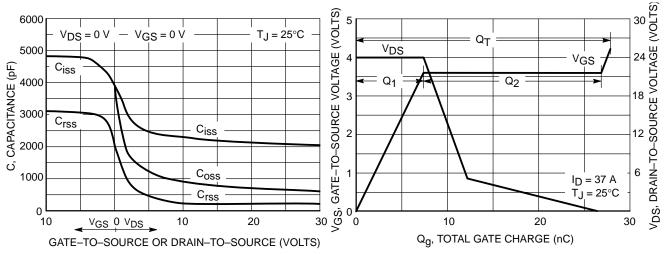


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

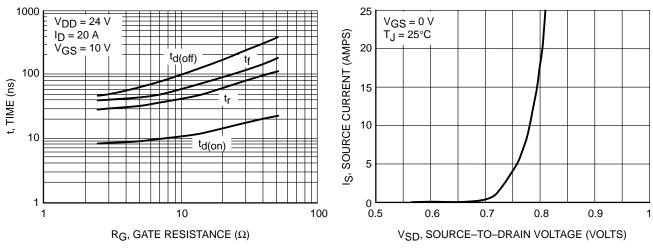


Figure 9. Resistive Switching Time Variations versus Gate Resistance

Figure 10. Diode Forward Voltage versus Current

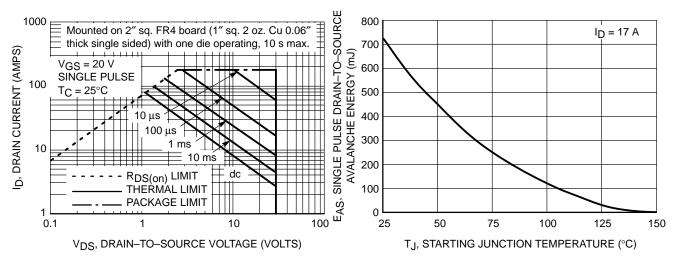


Figure 11. Maximum Rated Forward Biased Safe Operating Area

Figure 12. Maximum Avalanche Energy versus Starting Junction Temperature

SAFE OPERATING AREA

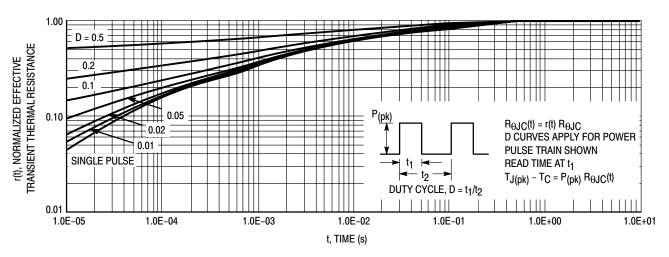


Figure 13. Thermal Response

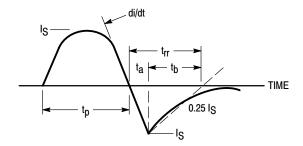
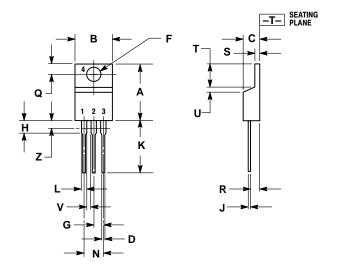


Figure 14. Diode Reverse Recovery Waveform

PACKAGE DIMENSIONS

TO-220 THREE-LEAD TO-220AB

CASE 221A-09 **ISSUE AA**



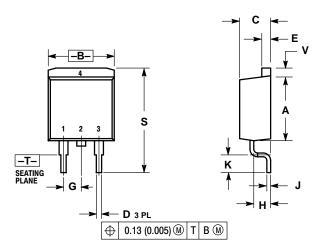
- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.
 3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

	INCHES MILLIMETER		IETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.570	0.620	14.48	15.75
В	0.380	0.405	9.66	10.28
C	0.160	0.190	4.07	4.82
D	0.025	0.035	0.64	0.88
F	0.142	0.147	3.61	3.73
G	0.095	0.105	2.42	2.66
H	0.110	0.155	2.80	3.93
7	0.018	0.025	0.46	0.64
K	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Ø	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
Т	0.235	0.255	5.97	6.47
5	0.000	0.050	0.00	1.27
٧	0.045		1.15	
Z		0.080		2.04

- STYLE 5:
 PIN 1. GATE
 2. DRAIN
 3. SOURCE
 4. DRAIN

PACKAGE DIMENSIONS

D²PAK CASE 418B-03 ISSUE D



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.

-		INC	HES	MILLIMETERS	
	DIM	MIN	MAX	MIN	MAX
	Α	0.340	0.380	8.64	9.65
	В	0.380	0.405	9.65	10.29
	С	0.160	0.190	4.06	4.83
ı	D	0.020	0.035	0.51	0.89
	Е	0.045	0.055	1.14	1.40
	G	0.100 BSC		2.54 BSC	
	Н	0.080	0.110	2.03	2.79
	J	0.018	0.025	0.46	0.64
	K	0.090	0.110	2.29	2.79
	S	0.575	0.625	14.60	15.88
	٧	0.045	0.055	1.14	1.40

- STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

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